

**Search Notes**

Application/Control No.

10/664,977

Examiner

VanThu Nguyen

Applicant(s)/Patent under  
Reexamination

HOSONO ET AL.

Art Unit

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	185.01 185.03 x 185.05 185.08 x	5/23/2005	VTN
	185.17		
	185.22 x		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	5/23/2005	VTN